# Linear Classifiers II 

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Linear Classifiers - supplement lecture

- Supplement to the lecture about learning Linear Classifiers (perceptron, ...)
- Better etalons by applying Fischer linear discriminator analysis.
- LSQ formulation of the learning task.

Fischer linear discriminant


- Dimensionality reduction
- Maximize distance between means, ...
- .... and minimize within class variance. (minimize overlap)

Figures from [1]

Projections to lower dimensions $y=\mathbf{w}^{\top} \mathbf{x}$



Figure from [2]

Projection to lower dimension $\mathbf{y}=W^{\top} \mathbf{x}$


Figure from [2]

Finding the best projection $y=\mathbf{w}^{\top} \mathbf{x}, y \geq-w_{0} \Rightarrow C_{1}$, otherwise $C_{2}$



This is just to make sure we understand geometric meaning of $\mathbf{w}, w_{0}$ and the separating hyperplane. Remind the vector notation w means the same as $\vec{w}$.

Finding the best projection $y=\mathbf{w}^{\top} \mathbf{x}, y \geq-w_{0} \Rightarrow C_{1}$, otherwise $C_{2}$

$$
m_{2}-m_{1}=\mathbf{w}^{\top}\left(\mathbf{m}_{2}-\mathbf{m}_{1}\right)
$$

Within class scatter of projected samples

$$
s_{i}^{2}=\sum_{y \in C_{i}}\left(y-m_{i}\right)^{2}
$$

Fischer criterion:

$$
J(\mathbf{w})=\frac{\left(m_{2}-m_{1}\right)^{2}}{s_{1}^{2}+s_{2}^{2}}
$$



Fischer criterion, max or min?


## Notes

$\mathrm{S}_{B}$ stands for the between class scatter matrix. Remind

$$
\left(\frac{f}{g}\right)^{\prime}=\frac{f^{\prime} g-f g^{\prime}}{g^{2}}
$$

hence we seek:

$$
2 \mathrm{~S}_{B} \mathbf{w}\left(\mathbf{w}^{\top} \mathbf{S}_{W} \mathbf{w}\right)=\left(\mathbf{w}^{\top} \mathrm{S}_{B} \mathbf{w}\right) 2 \mathrm{~S}_{W} \mathbf{w}
$$

the expressions within bracket are (unknown) scalars

$$
\mathbf{S}_{B} \mathbf{w}=\lambda \boldsymbol{S}_{W} \mathbf{w}
$$

leading to eigenvalue problem

$$
\mathrm{S}_{W}^{-1} \mathrm{~S}_{B} \mathbf{w}=\lambda \mathbf{w}
$$

However, $S_{B} \mathbf{w}$ is always in direction $\left(\mathbf{m}_{2}-\mathbf{m}_{1}\right)$, and scale is not important

$$
\mathbf{w}=\mathrm{S}_{W}^{-1}\left(\mathbf{m}_{2}-\mathbf{m}_{1}\right)
$$

## LSQ approach to linear classification

$$
\begin{gathered}
\mathbf{w}=\left[\begin{array}{l}
w_{0} \\
\mathbf{w}
\end{array}\right] \\
\mathrm{X} \mathbf{w}=\mathbf{b} \\
J(\mathbf{w})=\|\mathrm{X} \mathbf{w}-\mathbf{b}\|^{2}
\end{gathered}
$$



## Notes

Write dimensions to each symbol, $n$ may stand for the number of points, $d$ for dimensionality of the feature space.
Solving

$$
\frac{\partial J(\mathbf{w})}{\partial \mathbf{w}}=0
$$

yields $\mathbf{w}=\left(X^{\top} \mathbf{X}\right)^{-1} \mathbf{X}^{\top} \mathbf{b}$ Try to solve the above figure. We are looking for a separating hyperplane

$$
\mathbf{w}^{\top}\left[\begin{array}{c}
1 \\
x_{1} \\
x_{2}
\end{array}\right]=0
$$

and we want points in training set distant from the hyperplane

$$
\begin{gathered}
X=\left[\begin{array}{ccc}
1 & 1 & 2 \\
1 & 2 & 0 \\
-1 & -3 & -1 \\
-1 & -2 & -3
\end{array}\right] \\
\left.\mathbf{b}=\left[\begin{array}{lll}
1 & 1 & 1
\end{array}\right]\right]^{\top}
\end{gathered}
$$

Linear least squares not guaranteed to correctly classify everything on the training set. It's objective function not perfect for classification. Margins b were set quite arbitrarily.
Outliers can shift the decision boundary.

LSQ approach, better margins b?

$$
\begin{gathered}
X=\left[\begin{array}{cc}
1_{1} & X_{1} \\
-1_{2} & -X_{2}
\end{array}\right] \\
\mathbf{b}=\left[\begin{array}{c}
\frac{n}{n_{1}} 1_{1} \\
\frac{n}{n_{2}} 1_{2}
\end{array}\right]
\end{gathered}
$$

After some derivation it can be shown the LSQ solution is equivalent to Fisher linear discriminant instert into intermediate result when solving $\frac{\partial J(w)}{\partial w}=0$

$$
\mathrm{x}^{\top} \mathrm{X} \boldsymbol{w}=\mathrm{X}^{\top} \mathbf{b}
$$

## References

Further reading: Chapter 4 of [1], or chapter 3 and 5 of [2].
[1] Christopher M. Bishop.
Pattern Recognition and Machine Learning.
Springer Science+Bussiness Media, New York, NY, 2006.
PDF freely downloadable.
[2] Richard O. Duda, Peter E. Hart, and David G. Stork.
Pattern Classification.
John Wiley \& Sons, 2nd edition, 2001.

